<b>∕Φ F</b>	itute for form				Application Number 09/941,590 Filing Date: August 30, 2001		
TE O KAI	Sta	Information Disclosure Statement By Applicant (Use as many sheets as necessary)			First Named Inventor: Art Unit:	Naoki KUWATA	
12	il (Use				Examiner Name: Attorney Docket Number:	Y. K. Aggarwal	
Sec. S	been l	1	of	1			

**U.S. Patent Documents** 

0.0. I atent bocuments							
Examiner Initial	Cite No.	Document No.	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where Relevant Passages or Relevant Figures Appear		
	Α						
-	В						
	С						
	D						
	E						
	F						
	G						
	Н				:		
	1						
	J						
	K						

**Foreign Patent Documents** 

		· · · · · · · · · · · · · · · · · · ·		. alone boodinonto			
Examiner Initial	Cite No.	Foreign Patent Document No.	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where Relevant Passages or Relevant Figures Appear	Transl YES	ation NO
YWL	L	JP 8-88780	4/1996	Tanio		х	
414	М	JP 9-238265	9/1997	Ishii et al.		x	-
\ \d	N	JP 11-170634	6/1999	Vondran, Jr., et al.		х	
V.A.	0	JP 2000-172832	6/2000	Sekine et al.		х	<del></del>
718	Р	JP 2000-227848	8/2000	Matsuo	,	x	
	Q						

**Non Patent Literature Documents** 

		11011 I dicite Eliciatore Documents
Examiner Initial	Cite No.	Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
41	R	Abstract of Japanese Patent Publication 08-088780, Pub. Date: 02 April 1996, Patent Abstracts of Japan
74	S	Abstract of Japanese Patent Publication 09-238265, Pub. Date: 09 September 1997, Patent Abstracts of Japan
40	Т	Abstract of Japanese Patent Publication 11-170634 Pub. Date: 29 June 1999, Patent Abstracts of Japan
YA	U	Abstract of Japanese Patent Publication 2000-172832, Pub. Date: 23 June 2000, Patent Abstracts of Japan
40	V	Abstract of Japanese Patent Publication 2000-227848, Pub. Date: 15 August 2000, Patent Abstracts of Japan
	W	

<b>Examiner Signature</b>	409/2	Date Considered	0>/6/03
	N AS		

Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.